

Motion of SF_x^+ ($x=1-3,5$) and ion conversion in SF_6-N_2 mixtures

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This paper reports on the mass-analyzed measurement of the drift velocity of the positive SF_6 daughter ions, SF_x^+ ($x=1-3,5$) in the mixture of SF_6 with N_2 for SF_6 concentrations of 10% and 50%. A double mass spectrometer-drift tube was used for these measurements. The density-normalized electric field intensity E/N , was varied from 30 to 360 Td ($1 \text{ Td} = 10^{-17} \text{ V cm}^2$). We have found an increasingly monotonic dependence of the drift velocity with E/N , and an inverse dependence of the above parameter with the decrease of the SF_6 content in the mixture. A test of Blanc's law for the zero-field reduced mobilities of the above ions shows a fair qualitative agreement. No drift velocities of these ionic species could be measured in pure N_2 , since we found that these ions reacted strongly with the nitrogen molecules. The cases for SF_3^+ and SF_5^+ are discussed. A similar behavior was observed for the nitrogen ions drifting in pure SF_6 .

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I. INTRODUCTION

Sulfur hexafluoride is an outstanding high-voltage insulator, but it is also a powerful green house gas [1]. Efforts to reduce its environmental impact are focused on short-term solutions consisting of mixing it with gases with much less greenhouse effects, or even none, like nitrogen. It has been found, for instance, that mixtures containing between 40–50 % SF_6 in N_2 (by volume) are the optimum composition of an SF_6-N_2 mixture for use as a gaseous dielectric in place of pure SF_6 for both high-voltage insulation, and possibly for arc extinction and current interruption purposes [1,2]. Also, if the concentration of SF_6 in this mixture is around 10%, their dielectric characteristics for very fast transient voltages are very similar to those of pure SF_6 , and can be used for gas-insulated transmission lines [3,4].

SF_6-N_2 mixture has been the most widely studied among a fairly long list of gaseous substitutes to pure SF_6 . A fairly recent and accurate review on the extent of our knowledge on electron and ion swarm and transport properties is available [5]. It appears from this study, and also from the more recent literature published on this subject that, in contrast to pure SF_6 , for which research on the ion transport and chemistry has recently become available, [6–10], no ion transport data are available on this mixture. Rao and Olthoff [10], who measured the kinetic energy distributions for positive and negative ions sampled from an SF_6 discharge at elevated E/N , found that the ion-molecule reaction scheme was difficult to understand, especially that of the positive ions. The studies concerning the chemical decomposition induced by subjecting the gas to an electrical discharge have been focused mostly on the measurement of reaction rates for the formation of neutral oxidation by products from corona discharges [4,5,11]. Only a few studies have been carried out on the detection of ions formed by sparking the SF_6 mixed with

N_2 at impurity levels between 20–500 ppm [12]. Even at such small N_2 concentrations, ion molecule nitrogen-containing compounds such as $S_2F_8N^+$ exceed in intensity the peaks of those derived from SF_6 alone.

Knowledge of the ion drift velocity, for instance, is essential for evaluating mean ion energies and reaction rates, and also for plasma modeling, where this parameter sometimes influences sensitively the macroscopic discharge properties, like ion and current density. Whenever possible, mass-analyzed transport data are looked for, since complex molecules like SF_6 and N_2 bear a fairly complex reaction scheme, in which processes like dissociation and charge transfer play an important role. Moreover, a knowledge of the variation of the drift velocity with the density-normalized electric field intensity E/N is essential for situations in which the ions are far from thermal equilibrium with the neutral gas molecules.

This paper was motivated by the aim of providing the first set of ion transport data of SF^+ , SF_2^+ , SF_3^+ , and SF_5^+ in SF_6-N_2 mixtures over a relatively wide range of E/N between 30 and 360 Td ($1 \text{ Townsend} = 10^{-17} \text{ V cm}^2$), so as to assist the extent of our knowledge on the basic mechanisms prevailing in the gas discharge, and also to fulfill some of the needs for discharge modelling. SF_6 concentrations in the gas mixture of 10% and 50% were used.

II. APPARATUS

The drift tube with double mass spectrometry [13] used for this research is an improved version of the drift tube-mass spectrometer that was previously described in Ref. [7]. Briefly, a second quadrupole mass spectrometer (QMS) was attached to the exit of the original ion source. Primary ions, produced by electron impact in the hot-filament source, are focused electrostatically into the entrance of this new QMS having a mass range of 200 amu, and typical mass resolution of 0.1 amu. The ion source chamber can be moved over a distance from $0-38.70 \pm 0.05 \text{ cm}$ at 13 discrete positions, defined by a set of 3.1-cm-wide guard rings. After mass analysis, the ions are focused through an orifice of 0.2 mm

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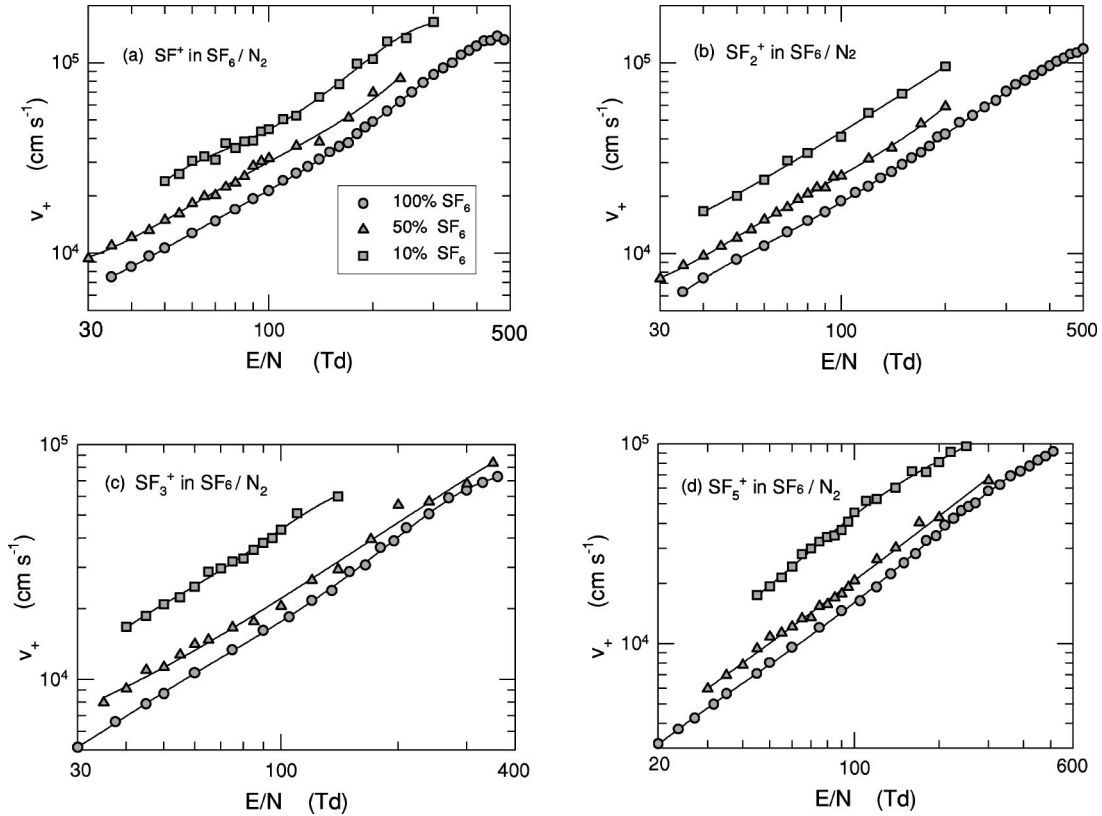


FIG. 1. Variation of the drift velocity of (a) SF^+ , (b) SF_2^+ , (c) SF_3^+ , and (d) SF_5^+ in SF_6/N_2 mixtures. The present data correspond to mixtures with 10% and 50% SF_6 , while the 100% SF_6 data were taken from Ref. [4].

into the drift space. Upon entrance into this region, the excess ion energy is relaxed by collisions with the gas neutrals over the first 3.1 cm of drift space, which is subjected to the same E/N conditions that prevail in the drift region. This process was found to be very efficient for many ion-neutral systems, since only a few mean free paths would suffice to achieve whole energy relaxation. This region is terminated by a pair of flat, parallel, copper meshes that serve as ion shutters, intended for mobility measurements.

After traversing the drift space, a sample of the drifting ions enters the ion detection chamber through a central orifice of 0.2 mm diameter, where a second QMS, followed by a continuous dynode multiplier, generates the output pulses that are routed into a multichannel scaler, where a time-of-arrival spectrum (TAS) is formed.

It has been shown [14] that for long drift distances (>5 cm) and relatively low gas pressures, (<50 Pa), the calculated mean, $\langle t \rangle$, of the TAS can very closely approximated to

$$\langle t \rangle = \frac{z}{v_+}, \quad (1)$$

where z is the drift distance, and v_+ is the ion drift velocity. Thus, a plot of $\langle t \rangle$ as a function of z would give a straight line, the slope of which is the inverse of v_+ . Normally, four consecutive ion source positions were used to obtain each v_+ .

The gas pressure in the drift chamber was controlled to within 0.3% of its set value by a servo valve coupled to a Baratron gauge with 0.05% full range accuracy. Drift distances could be read from a graduated scale to an accuracy of ± 0.5 mm. Two multichannel scalers were used for the present measurement. The time uncertainty was ± 1 μs . Thus, for typical ion transit times in the range 0.5–10 ms, the instrumental errors in the drift velocity ranged typically between 0.5–1.3%.

High purity grade (99.9%) SF_6 gas was used, while the purity of N_2 was 99.999%. Both gases were premixed in a separate cylinder, and its mixture was injected into the drift chamber without further purification. All measurements were taken over the ambient temperature range 293–310 K, for pressures between 0.66 and 13.3 Pa.

III. RESULTS AND DISCUSSION

A. Ion drift velocities in $\text{SF}_6\text{-N}_2$ mixtures

At least four different drift distances were used for each drift velocity measurement and, with the exception of a few points at the highest E/N values attained in this experiment, at least two pressures were used for each drift velocity measurement. The final uncertainties, resulting from averaging these v_+ values, are in the range 2–4%.

The drift velocities of SF^+ , SF_2^+ , SF_3^+ , and SF_5^+ in the $\text{SF}_6\text{-N}_2$ mixtures are shown plotted in Figs. 1(a) to 1(d), respectively, for SF_6 concentrations of 10% and 50%. Also

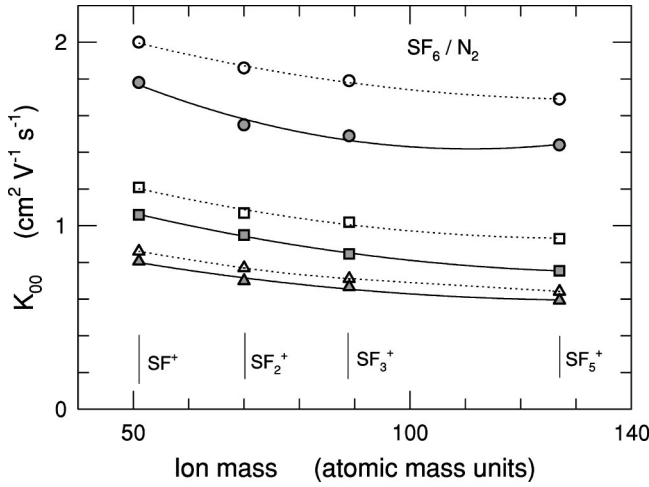


FIG. 2. Plot of the zero-field reduced mobility of SF⁺, SF₂⁺, SF₃⁺, and SF₅⁺ in SF₆/N₂ mixtures as a function of the mass of the above ions (closed symbols joined by solid lines), and the calculated values from Blanc's law (Open symbols joined by dotted lines) for the two gas mixtures. The zero-field reduced mobility of the above ions for pure SF₆ [7,9], and its calculated values from Eq. (4) are also shown.

displayed for comparison are the mass-analyzed drift velocities of the same ions in pure SF₆ [7,9]. In all cases, for a given E/N value, a marked increase in v_+ with a corresponding decrease in the SF₆ content in the mixture is observed. This behavior may be understood on the grounds of a stronger ion-neutral interaction with SF₆ than with N₂, since the mass ratio between SF₆ and N₂ is more than 5.2, and also because SF₆ has a larger dipole polarizability (6.55 Å³) [15] than N₂ (1.74 Å³) [16,17].

B. Test of Blanc's law for vanishingly small fields

It is known that at low E/N the ion drift velocity is proportional to E/N [16,17]. The proportionality constant K_{00} , referred as the zero-field reduced mobility, is given by

$$K_{00} = \frac{v_+}{N_0(E/N)}, \quad (2)$$

where $N_0 = 2.69 \times 10^{19} \text{ cm}^{-3}$ is gas density at STP. We have evaluated K_{00} from the first points of the above drift velocity curves, where the relation between v_+ and E/N is very approximately linear, with a slope close to unity, indicative of the point charge-induced dipole type of interaction. The resulting K_{00} values are displayed in Fig. 2 by the closed symbols for the 10% and 50% SF₆ concentrations, where a well-defined, smooth decrease of K_{00} with the increase in ion mass is clearly seen. For the sake of comparison, the zero-field reduced mobilities of the same ionic species drifting in pure SF₆ [7,9] have been plotted. In order to enhance the discussion, also displayed in this figure are the calculated zero-field reduced mobilities from Blanc's law [16,17] which, for a binary gas mixture is given as

$$\frac{1}{K_{mix, SF_x^+}} = \frac{[SF_6]/([SF_6] + [N_2])}{K(SF_x^+ \text{ in } SF_6)} + \frac{[N_2]/([SF_6] + [N_2])}{K(SF_x^+ \text{ in } N_2)} \quad (3)$$

where $[SF_6]$ and $[N_2]$ represent their respective concentrations in the mixture, and $x = 1-3,5$. The first term in Eq. (3) can be readily calculated from the measured mobility; however, the mobility value needed for the second term could not be measured, since the injected SF_x⁺ ions reacted strongly with the nitrogen molecules, giving rise to several fragment species by fast ion-molecule reactions that hindered the measurement of SF_x⁺ in N₂. These findings will be discussed in the next paragraph. However, we partially circumvented the absence of these values by calculating them with the polarization-limit formula for the zero-field mobility of an ion drifting in a pure gas [16,17]

$$K_{00} = \frac{13.56}{\sqrt{\mu_r \alpha_d}}, \quad (4)$$

where μ_r is the reduced mass of the ion and neutral, and α_d is the dipole polarizability of the neutral molecule or atom. The results are shown in Fig. 2 for the 10% and 50% SF₆ concentrations, showing that, in spite of the expected quantitative difference between calculated and measured values, the trends of the experimental curves are similar to those calculated, whereas the former are systematically higher than the latter by 10–25%. Obviously, a closer agreement would not have to be necessarily expected, since these theories are in principle based for monoatomic systems, and vanishingly small gas temperatures.

Also plotted in Fig. 2 are the calculated values of K_{00} with Eq. (4) for the SF₆ fragment ions, showing also the same qualitative agreement as that observed for the corresponding ionic species in the gas mixtures.

C. Interaction of the positive ions with N₂

Attempts to measure the drift velocity of SF_x⁺ (x = 1–3,5) in N₂ failed, since we found a rich and complex ion-molecule reaction scheme between these positive ions and nitrogen. The above is herein exemplified by Figs. 3 and 4, displaying the measured relative abundance of the fragment ions produced by the interaction of SF₃⁺ and SF₅⁺ in N₂. Two extreme N₂ pressures were chosen, well over the E/N range covered for the drift velocity measurements.

Looking at Fig. 3(a) that, for $p = 25$ mtorr (1 torr = 133.3 Pa), one observes that the injected SF₃⁺ breaks up into substantial amounts of S⁺, followed by SF⁺, and a steady increase of N₂⁺ that would certainly arise by charge transfer, and becomes predominant above $E/N = 700$ Td. At the other pressure extreme of 125 mtorr, shown in Fig. 3(b), S⁺ and SF⁺ still predominate, together with significant amounts F⁺ and SF₂⁺. Notice also that formation of N₂⁺ has become relatively insignificant at this pressure. In view of the fairly complex scheme and of the amount of product ions formed, one could only speculate in qualitative terms to

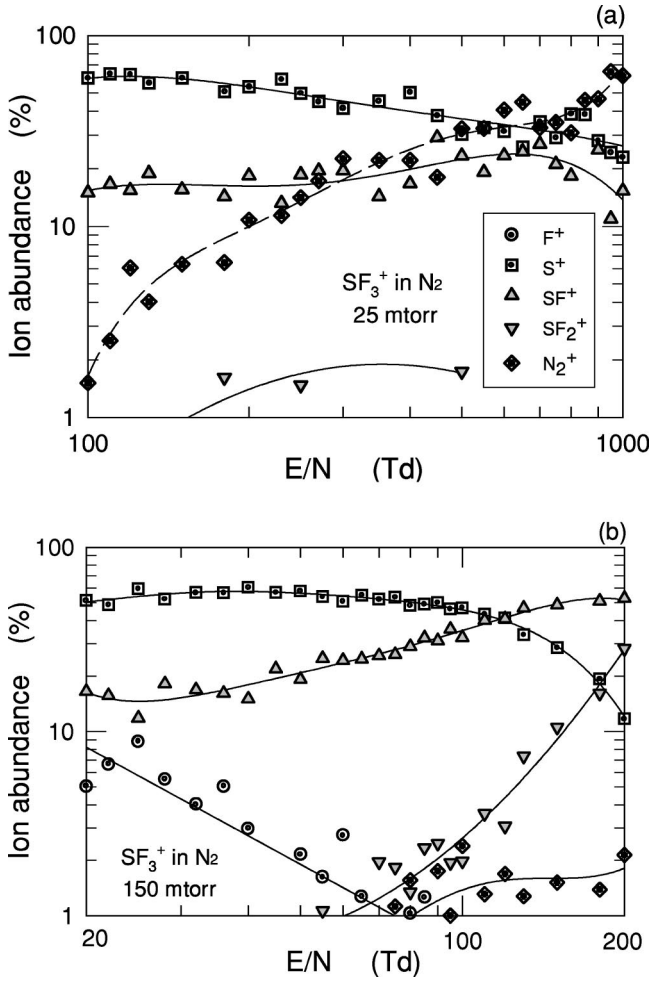
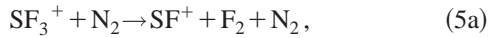


FIG. 3. The relative abundance of the ions formed by injecting SF_3^+ from the ion source into N_2 in the drift space, for pressures of (a) 25 mtorr and (b) 50 mtorr. Symbols are the same for both plots.

suggest the possible secondary and tertiary ion-molecule reactions



An equally interesting ion abundance pattern is observed in Fig. 4 for SF_5^+ injected into N_2 . It seems from Fig. 4(a), for $p=25$ mtorr that, the predominant resulting fragment ion is SF^+ , followed by almost equal amounts of S^+ and SF_2^+ , the latter increasing smoothly with a corresponding decrease of S^+ for $E/N > 200$ Td. N_2^+ is produced in smaller amounts, as compared with the previous SF_3^+ - N_2 case, only reaching a maximum abundance value of nearly 5% at $E/N=600$ Td. Although under these relatively low pressure conditions very little SF_3^+ is formed from SF_5^+ ,

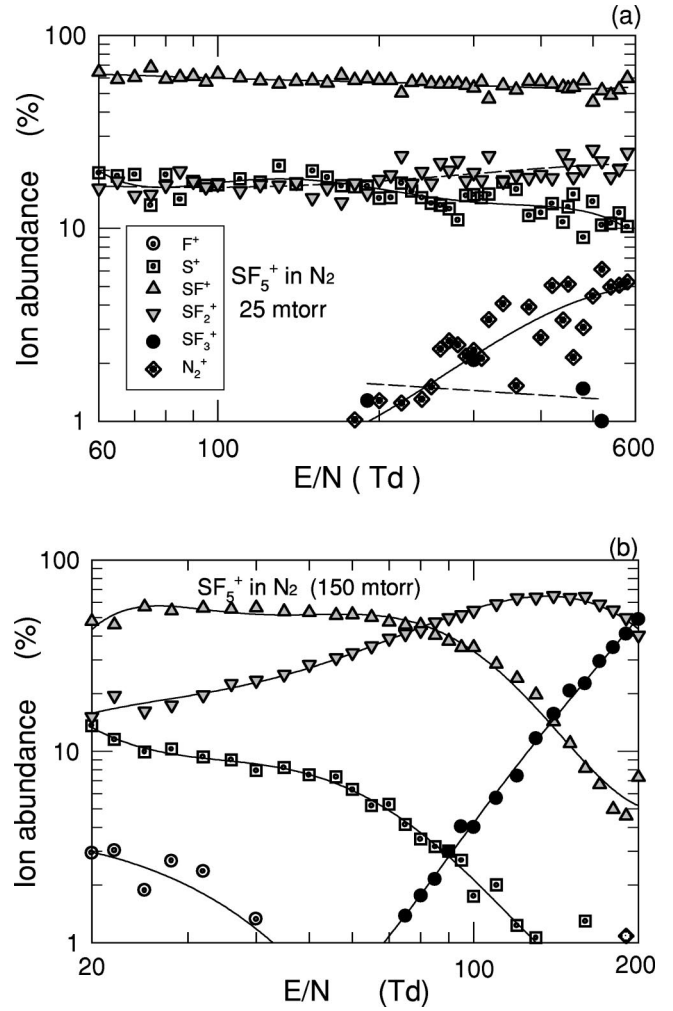
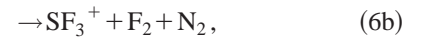
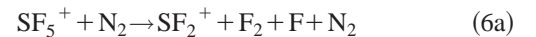
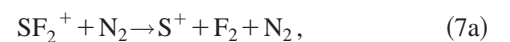


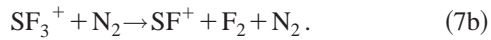
FIG. 4. The relative abundance of the ions formed by injecting SF_5^+ from the ion source into N_2 in the drift space, for pressures of (a) 25 mtorr and (b) 50 mtorr. Symbols are the same for both plots.

the situation reverses for $p=150$ mtorr, as is shown in Fig. 4(b), where the abundance of the SF_3^+ ion increases strongly with E/N , becoming close 50% at $E/N=200$ Td. In contrast with the predominance of S^+ and SF^+ at $p=25$ mtorr, the abundances of S^+ and SF^+ decrease sharply for $E/N > 50$ Td, with a corresponding steady increase of SF_2^+ and SF_3^+ , the latter probably arising from the collisional breakup of SF_5^+ . Thus we attempt to speculate that the ion-molecule processes responsible for the formation of the fragment ions are



with S^+ and SF^+ being possibly formed by the tertiary reactions





Finally, attempts to measure the mobility of N⁺ and N₂⁺ in pure SF₆ failed because their measured signals at the end of the drift space were either very weak or absent, thereby suggesting the presence of very fast reactions leading to the formation of SF_x⁺ (x=1–3,5) species. Indeed, this observation is congruent with the very high thermal reaction rate (at 300 K) reported by Fehsenfeld [18] of $4 \times 10^{-9} \text{ cm}^3 \text{ s}^{-1}$ for the reaction



No similar data were found for the reaction of N₂⁺ with SF₆.

IV. CONCLUSIONS

Although partially fulfilled, the original aims of the present work, rendered a fairly complete set of the drift ve-

locities for the most abundant ions produced in the drift tube, either by the ion source, or by ion-molecule reactions. The abundance studies reveal an interesting and complex reaction scheme, in which the breakup of SF₃⁺ and SF₅⁺ into lighter species, and the charge transfer reaction to form N₂⁺ are the outstanding features. The above results could be useful for building more realistic models of gas discharges in the SF₆-N₂ mixtures. Concerning the ion transport, the present set of data could be used to probe numerical procedures for the calculation of these drift velocities, using either interaction potentials or cross sections. Finally, under more fundamental grounds, it would be very advantageous to gain more insight into the very rich and complex ion-molecule reaction scheme that was observed.

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